

Search Notes**Application/Control No.**

10/522,576

Examiner

Tien Dinh

**Applicant(s)/Patent under
Reexamination**

PATEL ET AL.

Art Unit

3644

SEARCHED

Class	Subclass	Date	Examiner
244	164,165		
	169, 170		
	171		
	158.8		
	171.1		
	171.2	5/4/2007	TD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
244	169, 170		
	164, 165		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East text	5/8/2008	TD